Notice of References Cited

Application/Control No.

Applicant(s)/Patent Under Reexamination JEONG ET AL.

Examiner

Nathan M. Nutter

Applicant(s)/Patent Under Reexamination JEONG ET AL.

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-6,344,525 B1	02-2002	Lee et al.	525/384
	В	US-6,498,213 B2	12-2002	Jeong et al.	525/191
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			- 1 - 1 - 1 - 1 - 1 - 1 - 1 - 1 - 1 - 1
	К	US-			
	L	US-			
$\overline{}$	М	US-	<u></u>		

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р			• • • • • • • • • • • • • • • • • • • •		
	Q				***************************************	
	R					
	S					
	Τ					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.